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(12) **United States Design Patent** (10) **Patent No.:** **US D834,968 S**
Ishii (45) **Date of Patent:** **** *Dec. 4, 2018**

(54) **LIGHT WAVE DISTANCE MEASURING
THEODOLITE**

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(*) Notice: This patent is subject to a terminal disclaimer.

(**) Term: **15 Years**

(21) Appl. No.: **29/595,132**

(22) Filed: **Feb. 24, 2017**

(30) **Foreign Application Priority Data**

Dec. 21, 2016 (JP) 2016-027755

(51) **LOC (11) Cl.** **10-04**

(52) **U.S. Cl.**
USPC **D10/66**

(58) **Field of Classification Search**

USPC D10/66, 69, 70
CPC G01C 1/00–1/14; G01C 15/002; G02B
27/141

See application file for complete search history.

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(57) **CLAIM**

The ornamental design for a light wave distance measuring theodolite, as shown and described.

DESCRIPTION

The patent or application file contains a least one drawing executed in color. Copies of this patent or patent application publication with color drawing(s) will be provided by the Office upon request and payment of the necessary fee.

FIG. 1 is a front, right top perspective view of a light wave distance measuring theodolite showing my new design;

FIG. 2 is a rear, left top perspective view thereof;

FIG. 3 is a bottom plan view thereof;

FIG. 4 is a front elevational view thereof;

FIG. 5 is a right side elevational view thereof;

FIG. 6 is a left side elevational view thereof;

FIG. 7 is a top plan view thereof; and,

FIG. 8 is rear elevational view thereof.

1 Claim, 8 Drawing Sheets

(8 of 8 Drawing Sheet(s) Filed in Color)



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FIG. 1

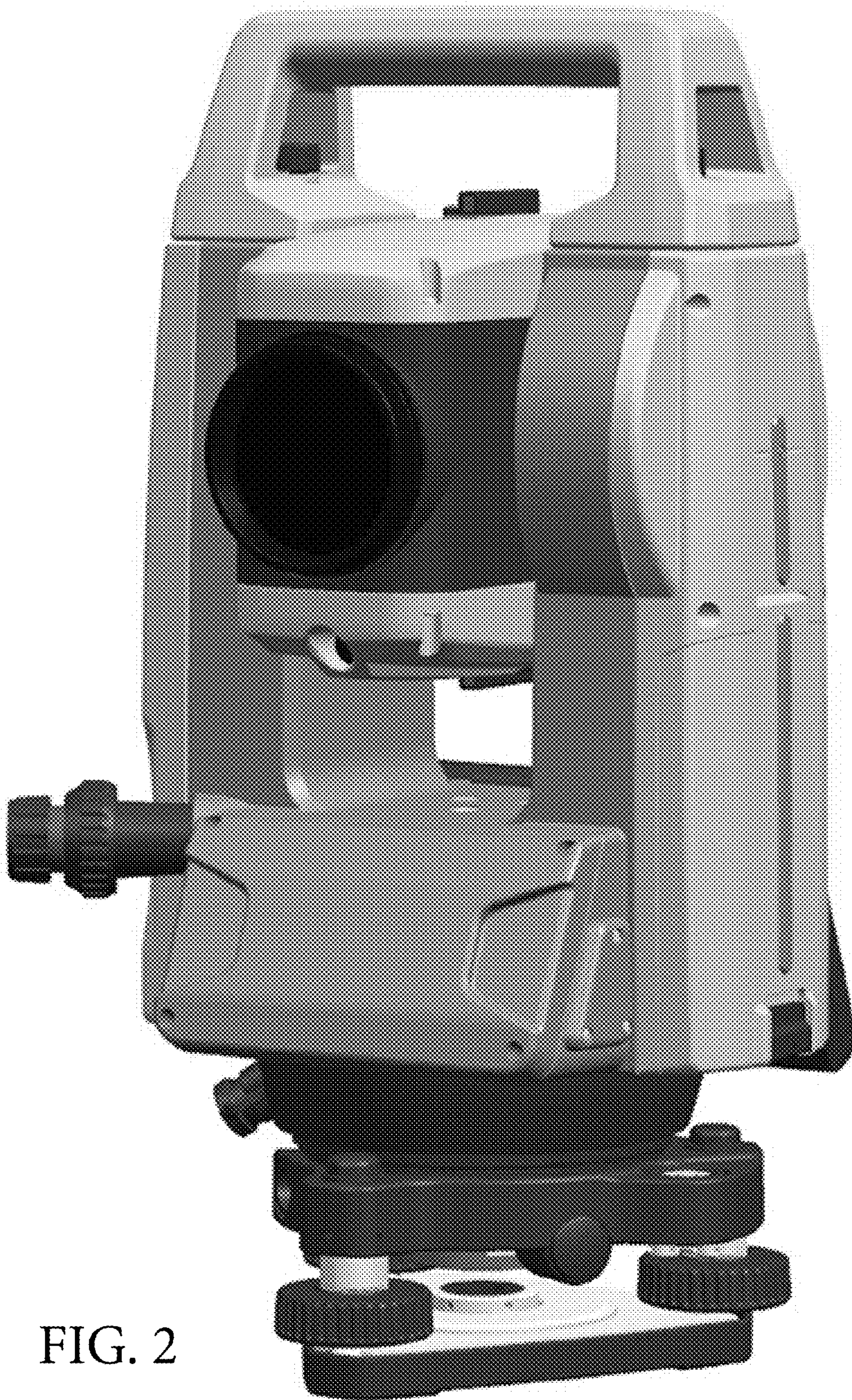


FIG. 2

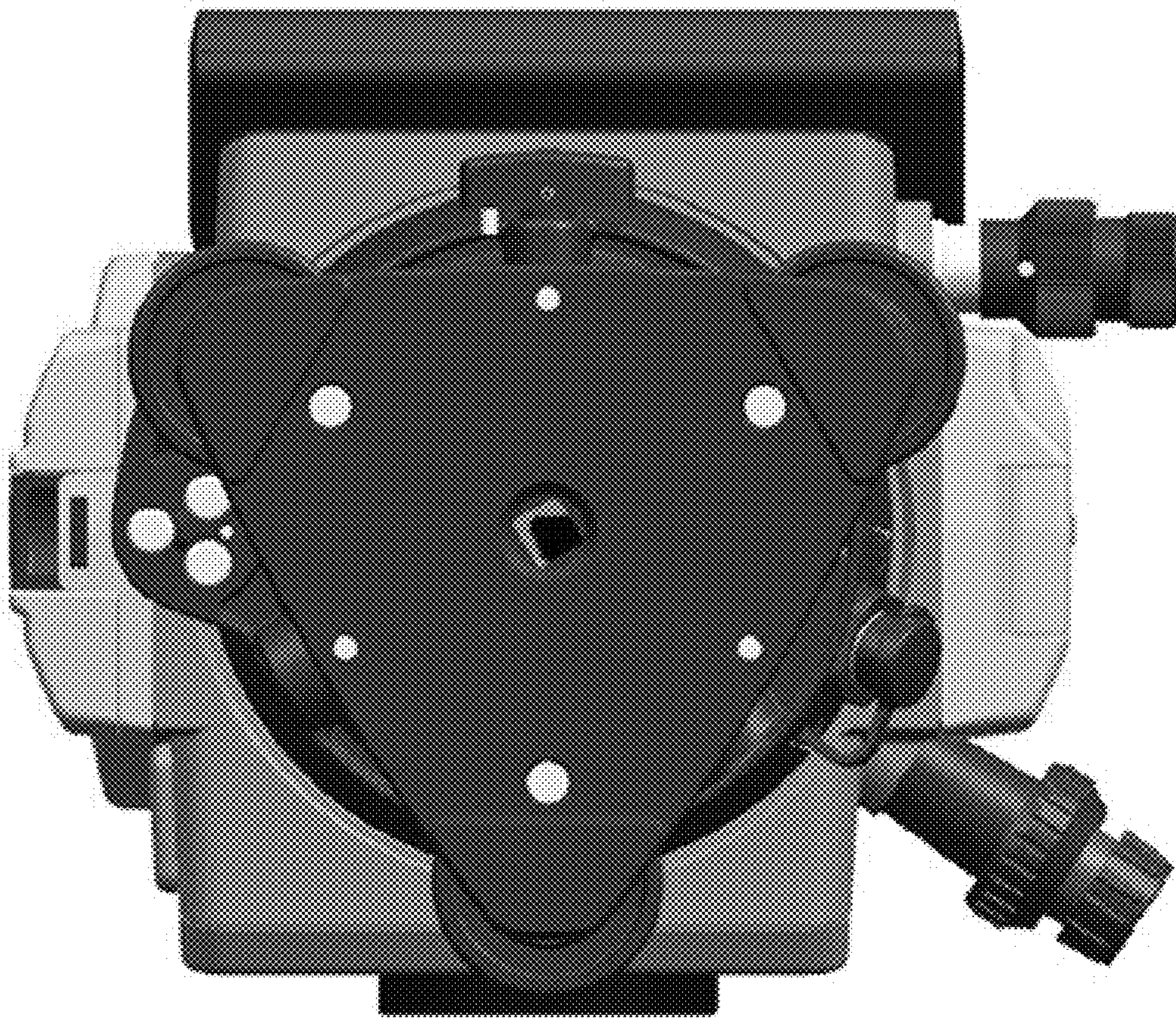


FIG. 3



FIG. 4

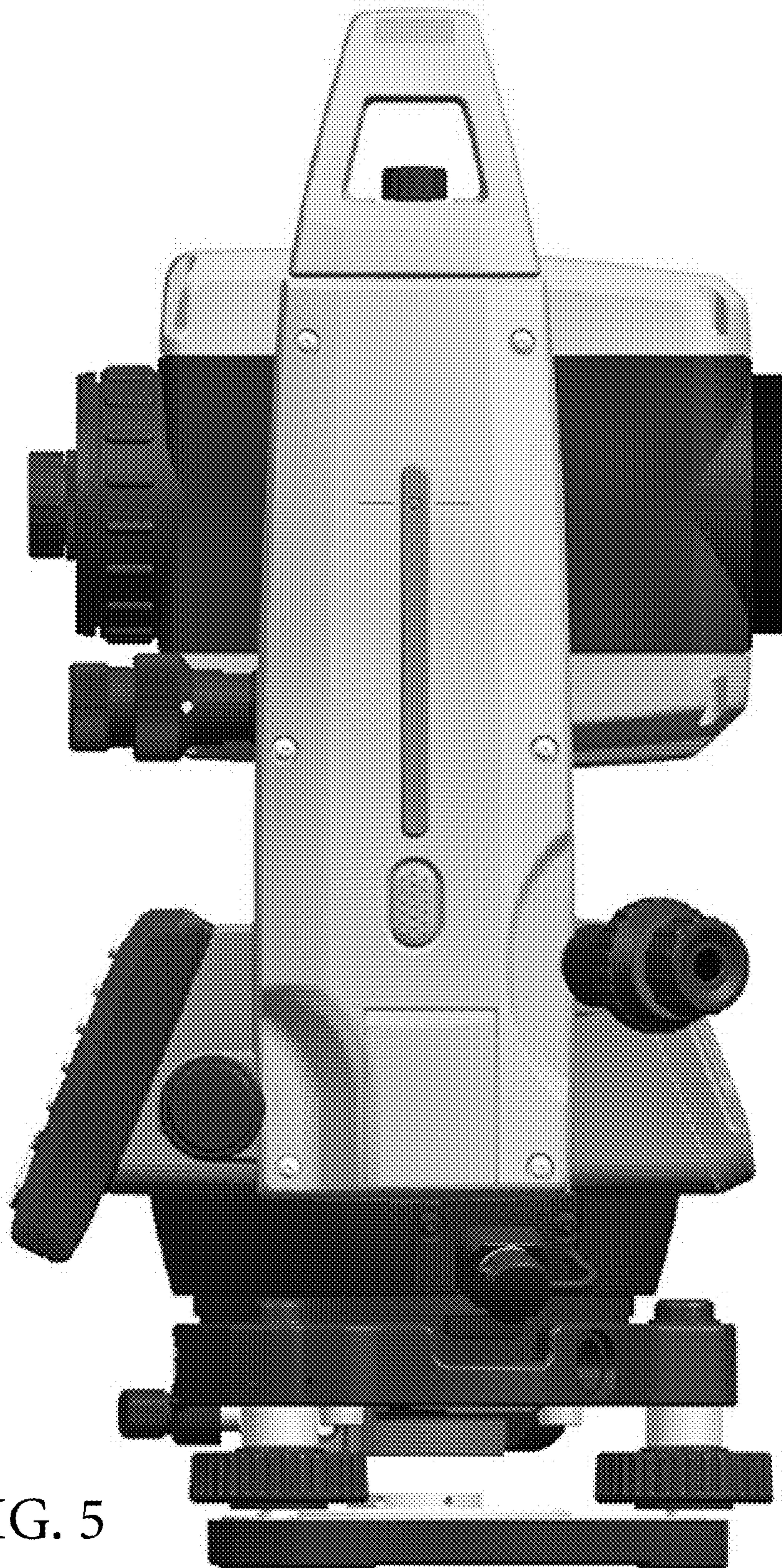


FIG. 5

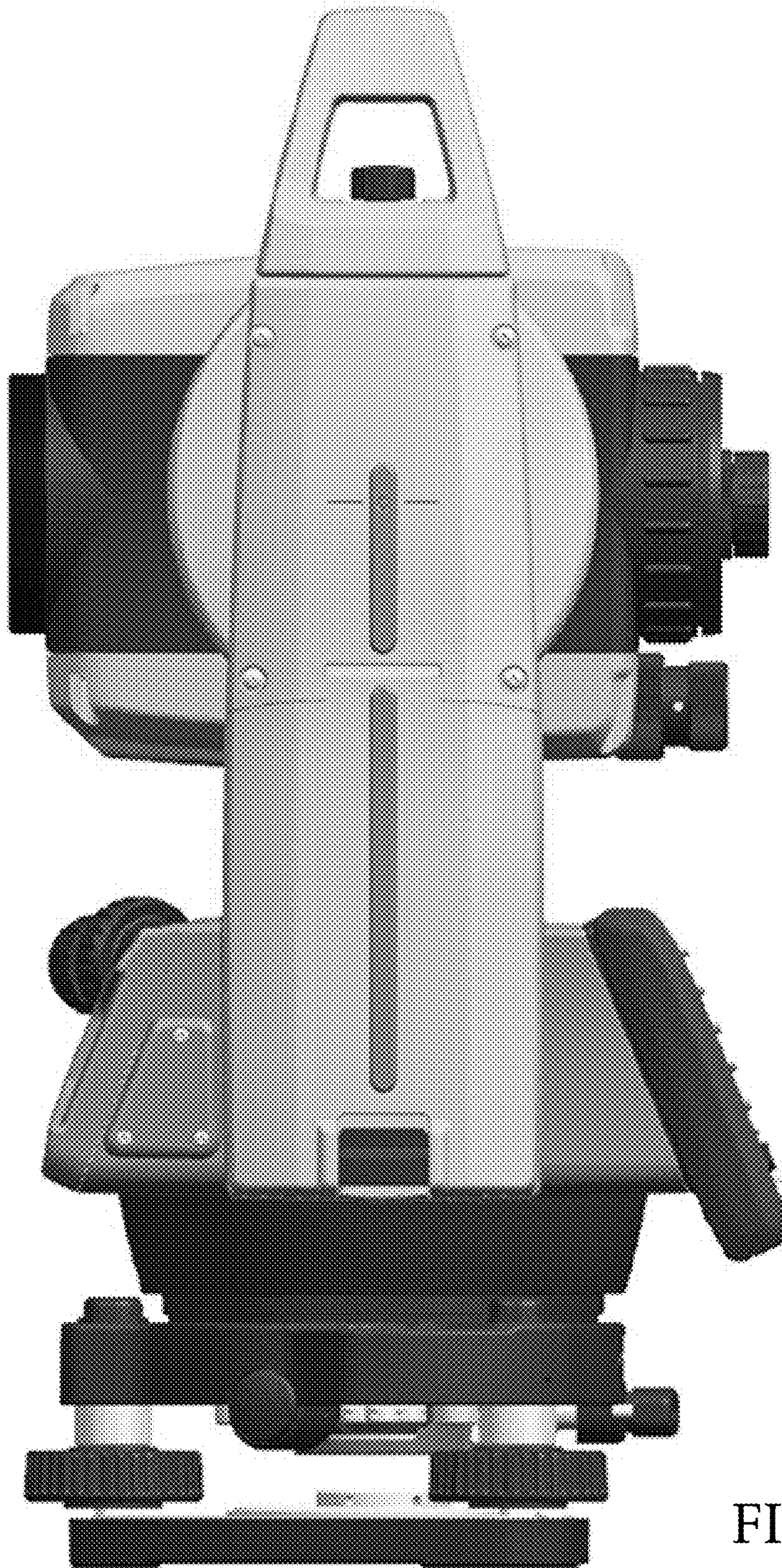


FIG. 6

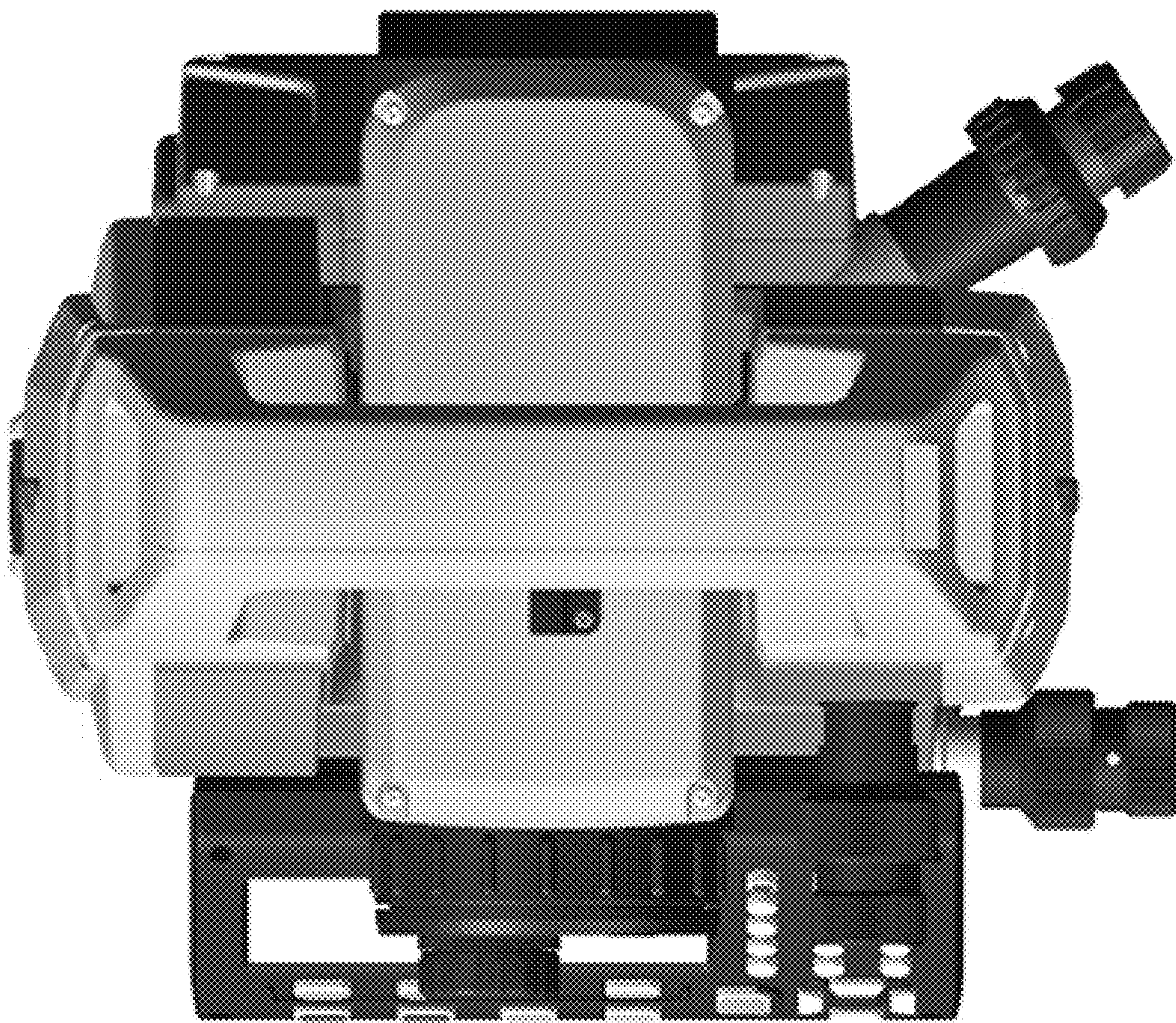


FIG. 7



FIG. 8